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Form PTO-1449 (modified)
List of Patents and Publications
For Applicant's Information
Disclosure Statement
(Use several sheets if necessary)

ATTY. DOCKET NO: 5150-44300

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SERIAL NO: 097595,003

SEP 14 2000

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APPLICANT: Vazquez et al.

FILING DATE: June 13, 2000

GROUP: Unknown

U.S. PATENT DOCUMENTS

EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION. YES/NO

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

[Signature] A1 Advanced Imaging, Special Report: Imaging and the Macintosh/Robust Image Databases, April 1991, pp. 18-32.

EXAMINER: *[Signature]*

DATE CONSIDERED: 11/18/02

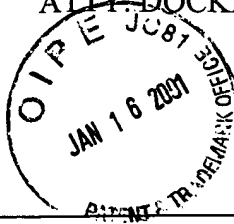
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JAN 22 2001

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APPLICANT: Vazquez et al.

FILING DATE: June 13, 2000

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U.S. PATENT DOCUMENTS

EXAM. INITIALS	REF. DES	Technology Center 2100 DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
DE	B19	5,940,296	08/17/1999	Meyer	717	109	
DE	B1	5,481,712	01/02/1996	Silver et al.	717	109	
DE	B2	6,094,526	Withdrawn	Marrion et al.	717	109	

FOREIGN PATENT DOCUMENTS

EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION. YES/NO

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

DE	B3	Optilab "Image Processing and Analysis Software for the Apple Macintosh™ II, User's Manual, dated 1990.					
DE	B4	MacUser, John Rizzo, Image Analyst and Enhance, July 1990, pp. 55-58.					
DE	B5	SPIE - The International Society for Optical Engineering, Steven Rosenthal and Larry Stahlberg, "Integrated Approach to Machine Vision Application Development", Volume 1386, November 8, 1990, pp. 158-162.					
DE	B6	Automatix News Release, www.applefritter.com/macclones/automatix/newsrelease, "Vision for Process Feedback and Control, 07/03/2000, pp 1-3.					
DE	B7	IPLab, Serious Image Processing for the Macintosh II, 1990.					
DE	B8	SPIE - The International Society for Optical Engineering, Michael S. Mort and Robert J. Fontana, "Low Cost Image Analysis Workstation Which is Menu Driven and Extensible," Volume 1232, February 4, 1990, pp. 380-389.					
DE	B9	IPLab™, User's Guide, Signal Analytics Corporation, 1991.					
DE	B10	MacGuide Magazine, Volume 2, Issue 4, Stuart Gitlow, M.D., "X-Ray Vision," June 1989, pp: 89-94.					
DE	B11	Ric Ford, Optimage Processes Scientific Images, 1994.					
DE	B12	Signal Analytics Corp., News Release, "Signal Analytics Brings Powerful Scientific Image Processing to the Macintosh II", February 1, 1990 (2 pgs.).					

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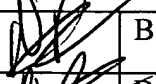



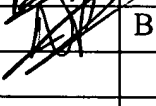
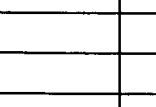
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	B13	IPLab, "Serious Scientific Image Processing for the Macintosh II", 1992 (4 pgs.).
	B14	IPLab, "Gives You Unparalleled Value", 1992, (6 pgs.).
	B15	Signal Analytics Corp., "IPLab Brings Affordable Scientific Image Processing to the Macintosh II", estimated 1990 (2 pgs.).
	B16	Automatix Inc., "A Seminar on Machine Vision & Image Analysis", 1993, (46 pgs.).
	B17	National Instruments, Measurement and Automation Catalogue, Interactive Vision Software, 1999, pp. 518-520.
	B18	MacUser, "Ultimage and IPLab Spectrum", July 1991, (5 pgs.).

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U.S. PATENT DOCUMENTS

EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>[Signature]</i>	D1	5,911,070	06/08/99	Solton et al.			

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